Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,671	MUKAI ET AL.	
Examiner	Art Unit	
Trinh Vo Dinh	2821	

SEARCHED					
CI	ass	Subclass	Date	Examiner	
343		700ms 702	4/8/2005 j	T.D	
		829 845			
		846-848			
		853 893			
		895 737			
		IPC			
Н)1Q	1/38	4/11/2005	T.D	
		1/24			
		1/48			

INTERFERENCE SEARCHED						
Cla	ISS	Subclass	Date		Examiner	
34	3	700ms 702	4/11/2005		T.D	
		823 846				
		853	V		V	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East search (Subclasses, inventors). Search for copending applications using eDAN	4/8/2005	T.D
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